



UT5N03Z

Power MOSFET

5.0A, 30V N-CHANNEL POWER MOSFET

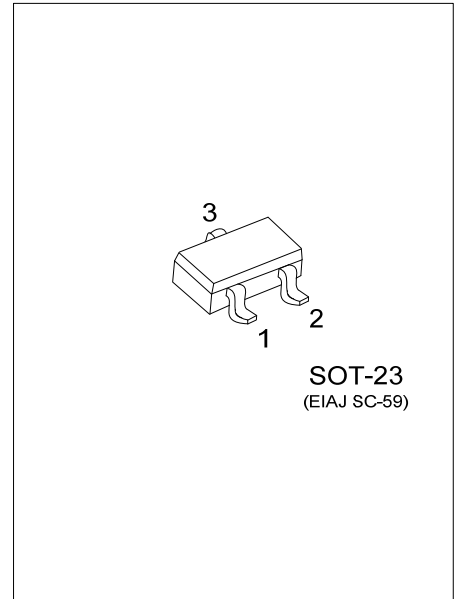
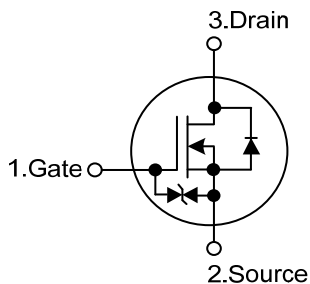
DESCRIPTION

The UTC **UT5N03Z** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} \leq 23 \text{ m}\Omega @ V_{GS} = 10V, I_D = 2.5A$
- * $R_{DS(ON)} \leq 37 \text{ m}\Omega @ V_{GS} = 4.5V, I_D = 2.5A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness
- * With ESD Protected

SYMBOL



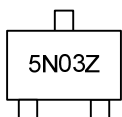
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT5N03ZL-AE3-R	UT5N03ZG-AE3-R	SOT-23	G	S	D	Tape Reel

Note: Pin Assignment: G: Gate S: Source D: Drain

<p>UT5N03ZG-AE3-R</p> <p>(1)Packing Type</p> <p>(2)Package Type</p> <p>(3)Green Package</p>	<p>(1) R: Tape Reel</p> <p>(2) AE3: SOT-23</p> <p>(3) G: Halogen Free and Lead Free, L: Lead Free</p>
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MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_c=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage (Note 2)		V _{DSS}	30	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Continuous	I _D	5	A
	Pulsed	I _{DM}	10	A
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	42	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.2	V/ns
Power Dissipation		P _D	1.2	W
Junction Temperature		T _J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 1mH, I_{AS} = 9.2A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C

4. I_{SD} ≤ 5.0A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ _{JA}	125	°C/W
Junction to Case	θ _{JC}	104	°C/W

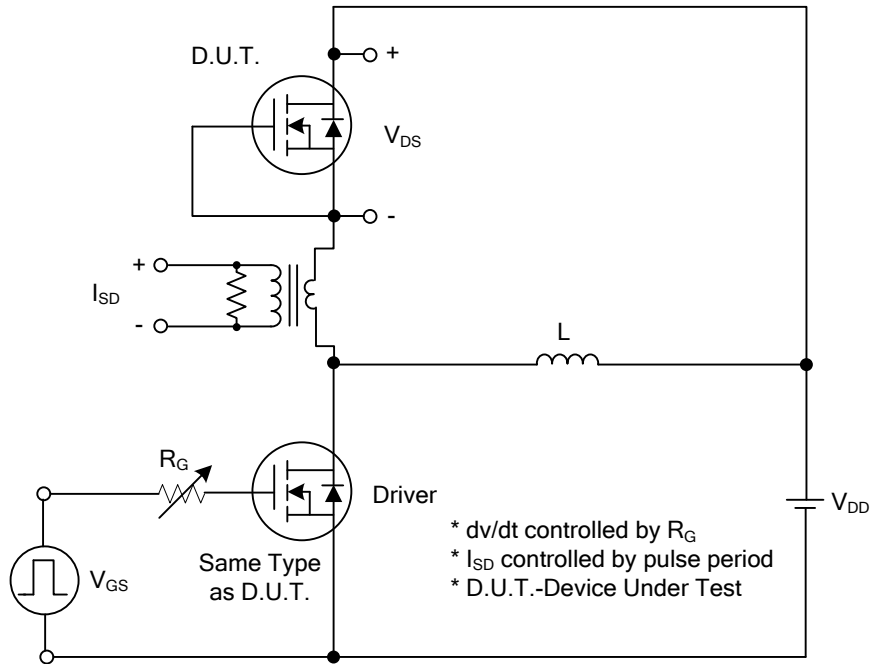
■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	30			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate- Source Leakage Current	Forward	I _{GSS}	V _{GS} =20V, V _{DS} =0V			10	μA
	Reverse		V _{GS} =-20V, V _{DS} =0V			-10	μA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	1.0		3.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =2.5A			23	mΩ
			V _{GS} =4.5V, I _D =2.5A			37	mΩ
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	V _{DS} =15V, V _{GS} =0V, f=1.0MHz		471		pF
Output Capacitance		C _{OSS}			129		pF
Reverse Transfer Capacitance		C _{RSS}			110		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		Q _G	V _{DS} =24V, V _{GS} =10V, I _D =5.0A, (Note 1, 2)		19		nC
Gate-Source Charge		Q _{GS}			2		nC
Gate-Drain Charge		Q _{GD}			6		nC
Turn-On Delay Time (Note 1)		t _{D(ON)}	V _{DD} =15V, V _{GS} =10V, I _D =5.0A, R _G =3Ω (Note 1, 2)		6		ns
Turn-On Rise Time		t _R			14		ns
Turn-Off Delay Time		t _{D(OFF)}			17		ns
Turn-Off Fall Time		t _F			21		ns
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS							
Maximum Body-Diode Continuous Current		I _S				5	A
Maximum Body-Diode Pulsed Current		I _{SM}				10	A
Drain-Source Diode Forward Voltage (Note 1)		V _{SD}	I _S =5.0A, V _{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =5.0A, V _{GS} =0V		108		ns
Reverse Recovery Charge		Q _{rr}	di/dt=100A/μs		102		μC

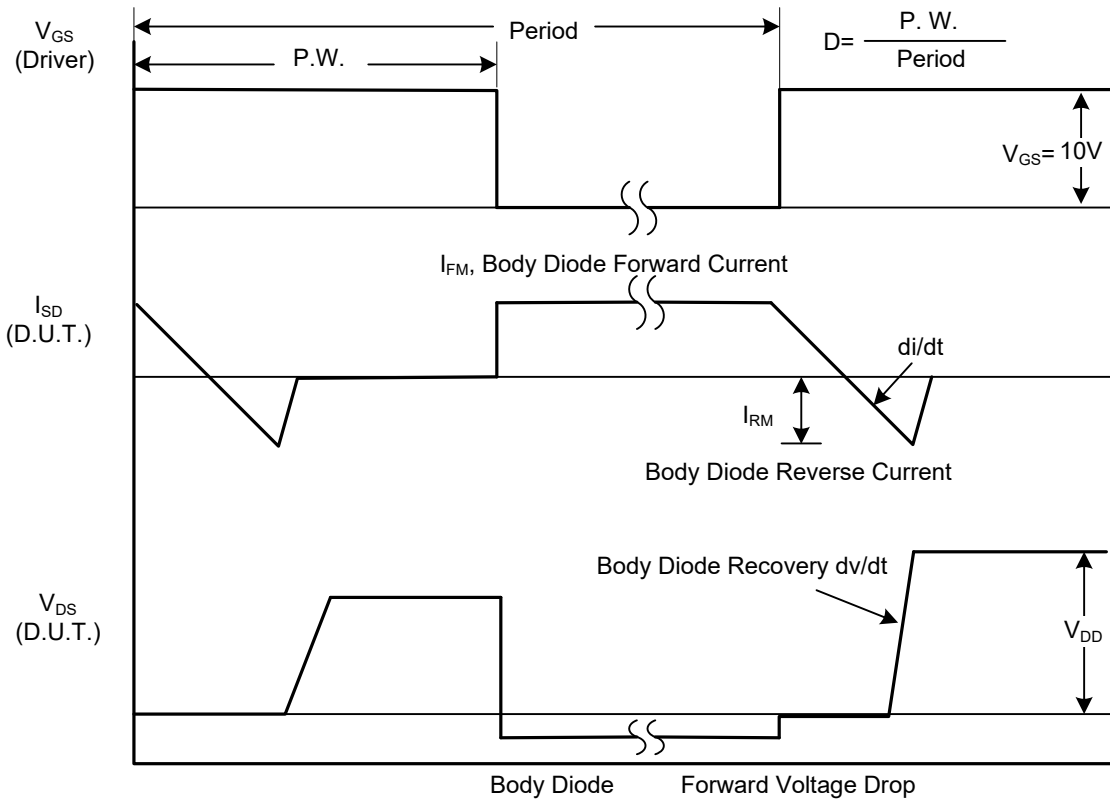
Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

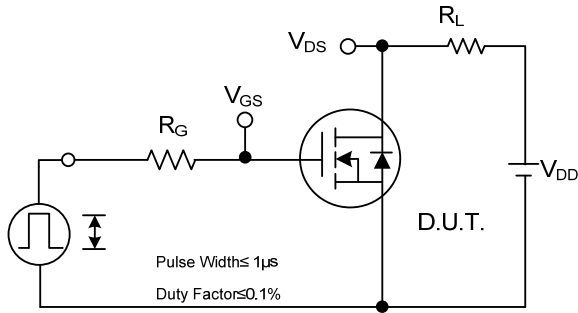


Peak Diode Recovery dv/dt Test Circuit

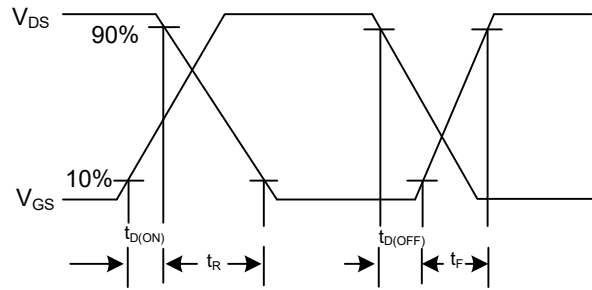


Peak Diode Recovery dv/dt Waveforms

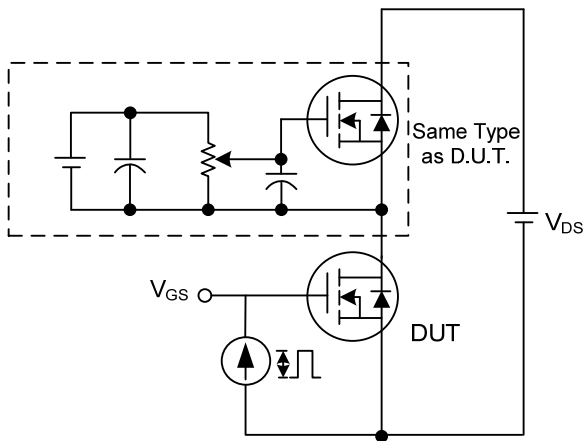
TEST CIRCUITS AND WAVEFORMS



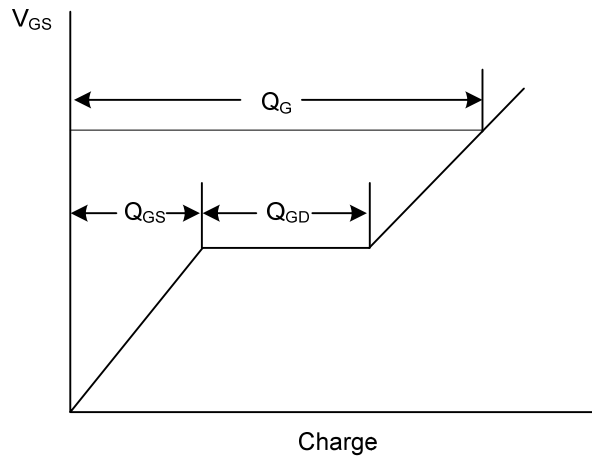
Switching Test Circuit



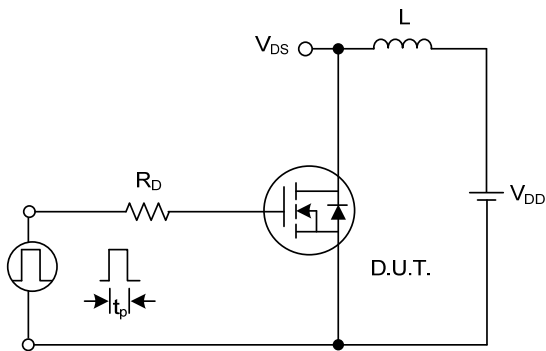
Switching Waveforms



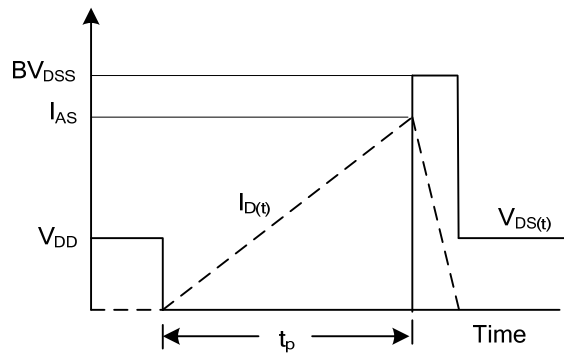
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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